

B/A

Docket No.: 67162-017

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE



Re Application of

: Customer Number: 20277

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Masayuki IKETANI

: Confirmation Number: 7350

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Serial No.: 10/619,476

: Group Art Unit: 2818

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Filed: July 16, 2003

: Allowed: February 10, 2004

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: Examiner: T. Q. Phan

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For: SEMICONDUCTOR INTEGRATED CIRCUIT DEVICE CAPABLE OF
SHORTENING PERIOD REQUIRED FOR PERFORMING DATA RETENTION TEST

AMENDMENT UNDER 37 CFR 1.312

Mail Stop Issue Fee
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Please amend the above-identified application as follows: